

IS450

OPIC Light Detector with Built-in Signal Processing Circuit for Light Modulation System

Features

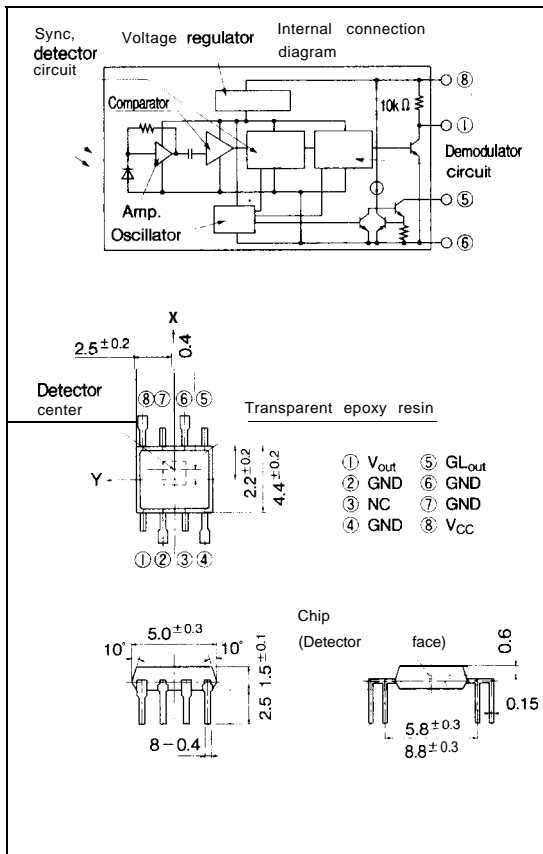
1. Impervious to external disturbing lights due to light modulation system
2. Built-in pulse driver circuit and sync. detector circuit on the emitter side
3. A wide range of operating supply voltage (V_{CC} : 4.5 to 9V)
4. 1.5mm thin dual-in-line package

Applications

1. Optoelectronic switches
2. Copiers, printers, facsimiles

Outline Dimensions

(Unit : mm)



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OPIC Light Detectors

Absolute Maximum Ratings (Ta= 25°C)

Parameter	Symbol	Rating	Unit
Supply voltage	V_{CC}	-0.5 to 9	V
Output	Output voltage	9	V
	Output current	I_O	16 mA
*GL output	Output voltage	V_{GL}	9 V
Power dissipation	P	150	mW
Operating temperature	T_{opr}	-25 to +60	°C
Storage temperature	T_{str}	-40 to +85	°C
*Soldering temperature	T_{sol}	260	°C

*1 Applies to GL_{out} terminal.

*2 For 5 seconds at the position of 1mm from the bottom face of resin package.

* "OPIC" (Optical IC) is a trademark of the SHARP Corporation. An OPIC consists of a light-detecting element and signal-processing circuit integrated onto a single chip.

■ Electro-optical Characteristics

($V_{CC}=5V$, $T_a=25^\circ C$)

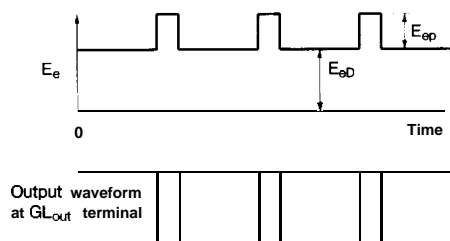
Parameter		Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Operating supply voltage		V_{CC}		4.5	—	9	v
Supply current		I_{CC}	V_O, GL_{out} terminals shall be opened.	—	3.5	7.0	mA
output	Low level output voltage	V_{OL}	$I_{OL}=16mA, E_{VP}=500lx, E_{VD}=0$ *3	—	0.15	0.35	v
	High level output voltage	V_{OH}	$E_{VP}=E_{VD}=0$ *3	4.95	—	—	v
	Output short-circuit current	I_{OS}	$E_{VP}=E_{VD}=0$ *3	0.25	0.5	1.0	mA
GL output	Low level output current	I_{GL}	$V_{GL}=1.2V$	40	55	70	mA
	*4 Pulse cycle	t_p		70	130	220	μs
	*4 Pulse width	t_w		4.4	8	13.7	μs
*5 "Low→High" threshold irradiance		E_{epLH}	$E_{eD}=0$, Light emitting diode ($\lambda p=940nm$)	—	0.5	2.1	$\mu W/mm^2$
* "High→Low" threshold irradiance		E_{epHL}		—	0.8	2.2	
Hysteresis		E_{epLH}/E_{epHL}		0.45	0.65	0.95	—
Response time	*6 "High→Low" propagation delay time	t_{pHL}	*6	—	400	670	μs
	"Low→High" propagation delay time	t_{pLH}	*6	—	400	670	μs
*7 External disturbing light illuminance		E_{VDX}	*3 $E_{an}=6.6 \mu W/mm^2, \lambda p=940nm$	750	3600	—	lx

*3 E_{ep} represents illuminance of signal light in sync with the low level timing of output at GL_{out} terminal.

Light source : Infrared light emitting diode ($\lambda p=940nm$)

E_{eD} represents illuminance of DC light. For detail, see Fig. 1. Note that the light source in CIE standard light

Fig. 1



(Note) Fig. 1 shows the output voltage waveform at GL_{out} terminal with IS450 connected as shown in Fig.3.

*4 Pulse cycle (t_p), pulse width (t_w) are defined as shown in Fig. 2.

The waveform shown in Fig. 2 is the output voltage waveform at GL_{out} terminal with S450 connected as shown in Fig. 3.

Fig. 2

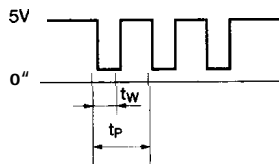
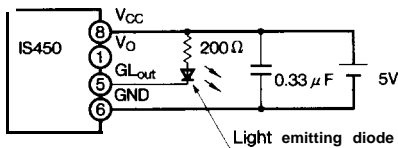
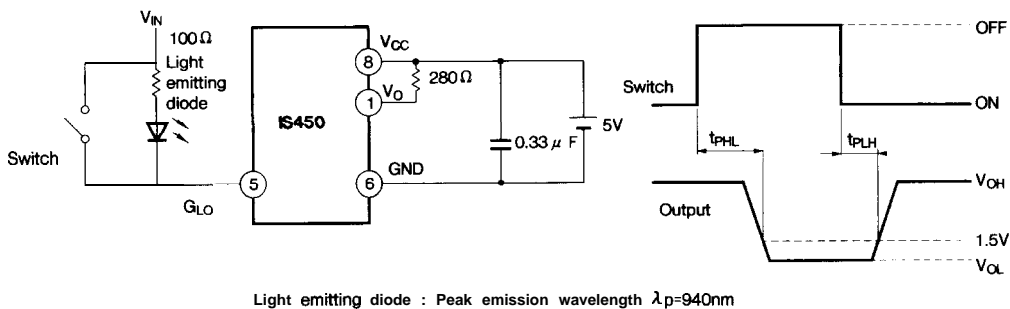


Fig. 3



- *5 Defined as E_{ep} that causes the output to go "Low→High" (or "High→Low").
- *6 Test circuit for response time, threshold irradiance is shown in Fig.4.

Fig. 4



- *7 E_{VDX} :Defined as the E_{VD} at the limit of normal operation range

Fig. 5 Power Dissipation vs. Ambient Temperature

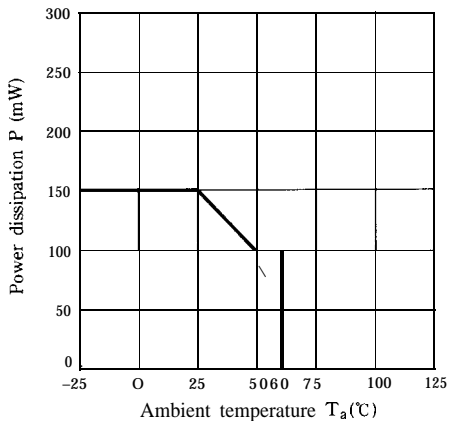


Fig. 6 Low Level Output Voltage vs. Low Level Output Current

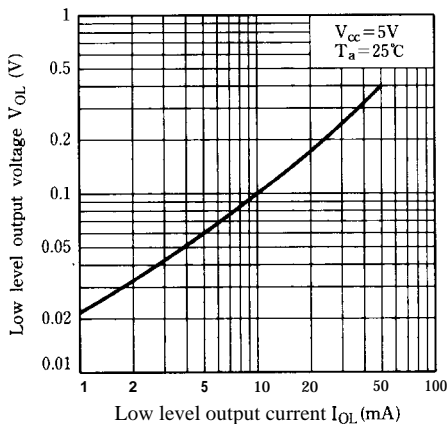


Fig. 7 Low Level Output Voltage vs. Ambient Temperature

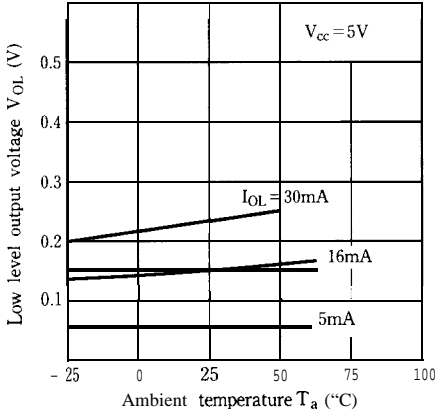


Fig. 8 Supply Current vs. Supply Voltage

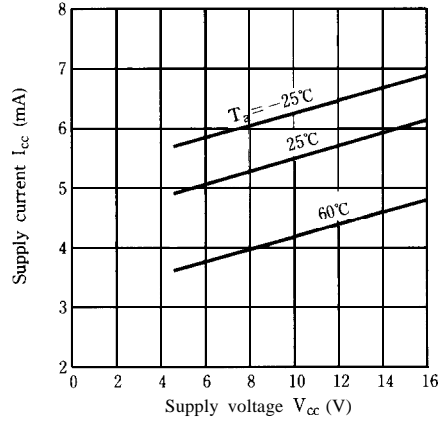


Fig. 9 Low Level Output Current vs. Supply voltage

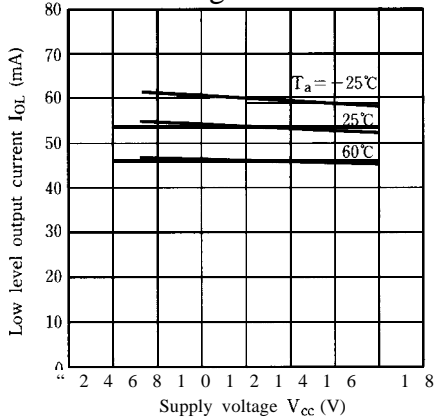


Fig.10 Sensitivity Diagram ($T_a = 25^{\circ}$ C)

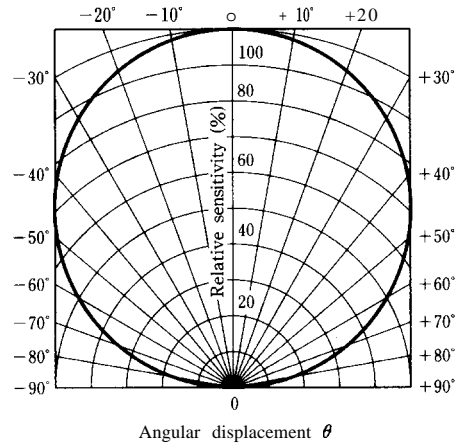
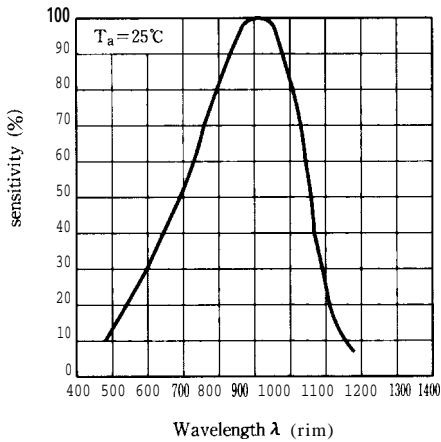
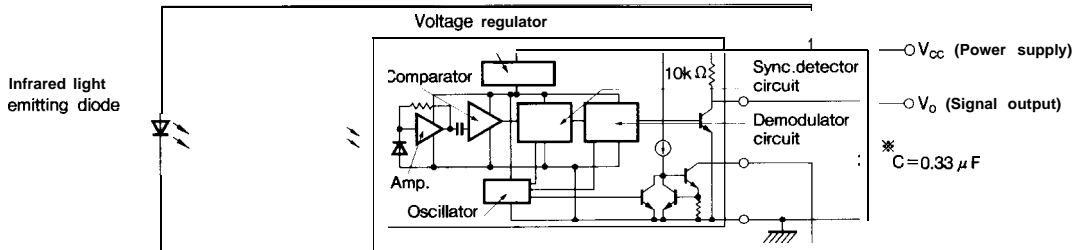


Fig.11 Spectral Sensitivity



Basic Circuit



* In order to stabilize power supply line, connect a by-pass capacitor of $0.33 \mu F$ or more between V_{CC} and GND near the device

● Please refer to the chapter "Precautions for Use" (Page 78 to 93)